

SEW

HT-03-027

May 21, 2004



To: Commissioner for Patents
P.O.Box 1450
Alexandria, VA 22313-1450

Fr: George O. Saile, Reg. No. 19,572
28 Davis Avenue
Poughkeepsie, N.Y. 12603

Subject: | Serial No. 10/816,040 04/01/04 |
Glen Garfunkel
SIDE PINNED MAGNETIC RECORDING
SENSOR
| _____ |

INFORMATION DISCLOSURE STATEMENT

Enclosed is Form PTO-1449, Information Disclosure Citation
In An Application.

The following Patents and/or Publications are submitted to
comply with the duty of disclosure under CFR 1.97-1.99 and
37 CFR 1.56.

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being
deposited with the United States Postal Service as first class
mail in an envelope addressed to: Commissioner for Patents,
P.O. Box 1450, Alexandria, VA 22313-1450, on May 24, 2004.

Stephen B. Ackerman, Reg.# 37761

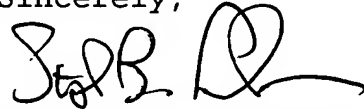
Signature/Date SPB [Signature] 5/24/04

HT-03-027

U.S. Patent 6,636,397 to Gill, "Lead Overlay Spin Valve Sensor with Antiferromagnetic Layers in Passive Regions for Stabilizing a Free Layer," discloses two structures featuring a split AFM layer.

U.S. Patent Application Publication US 2003/0179507 A1 to Freitag et al., "Exchange Biased Self-Pinned Spin Valve Sensor with Recessed Overlaid Leads," describes AFM layers in wing portions of a spin valve sensor.

Sincerely,

A handwritten signature in black ink, appearing to read 'S.B. Ackerman', with a stylized flourish extending to the right.

Stephen B. Ackerman,
Reg. No. 37761

Form PTO-1449

INFORMATION DISCLOSURE CITATION
IN AN APPLICATION

(Use several sheets if necessary)

Docket Number (Optional)

HT-03-027

Application Number

10/816,040

Applicant

Glen Garfunkel

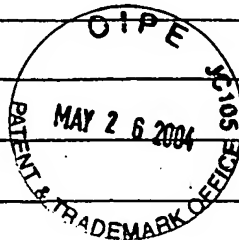
Filing Date

04/01/04

Group Art Unit

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILED DATE IF APPROPRIATE
	6636397	10/24/03	Gill	360	324.12	3/20/01



FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Portion of Pages, Etc.)

-	US Patent App. Pub. US 2003/0179507 A1 to Freitag et al., Pub. Date 9/25/03, Filed 3/21/02, US cl. 360/322.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.